

**Notice of References Cited**

Application/Control No.

09/577,005

Applicant(s)/Patent Under

Reexamination

ASAKURA ET AL.

Examiner

Delia M. Ramirez

Art Unit

1652

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Bormann et al., GenBank accession number X59404, 1992 ✓
	V	Eikmanns et al., GenBank accession number X66112, 1994 ✓
	W	Nakamura et al., GenBank accession number AB025424, April 1999 ✓
	X	Eikmanns et al., GenBank accession number X71489, 1995 ✓

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